

IN THE CLAIMS

Please cancel claims 1-13 and add 14-17 as follows:

14. A method of manufacturing a semiconductor apparatus comprising the steps of:

5 forming a bypass film from an insulation film through which a leak current is able to easily flow as compared with a gate insulation film of a MIS transistor and forming a gate electrode which extends above said bypass film; and

10 performing a work process directed to the manufacture of the semiconductor apparatus while performing destaticization through said bypass film.

15. A method of manufacturing a semiconductor apparatus according to claim 14, further comprising the steps of:

selectively etching a gate insulation film of a region forming said bypass film to make the same thin after said gate insulation film of said MIS transistor has been formed; and

15 forming said gate electrode to have a pattern extending from a region of said MIS transistor to a portion above said bypass film.

20 16. A method of manufacturing a semiconductor apparatus according to claim 14, further comprising the steps of:

25 forming a first gate insulation film of said MIS, transistor, then selectively etching off said first gate insulation film at a region of said bypass film and forming a second gate insulation film which will become said bypass film; and

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then forming said gate electrode to have a pattern extending from a region of said MIS transistor to a portion above said bypass film.

17. A method of manufacturing a solid state image device
5 comprising the steps of:

forming a bypass film through which a leak current is able to easily flow as compared with a gate insulation film, between a wiring for connecting each gate electrodes of a MOS transistor forming the pixel and a drain region, and

10 carrying out a work process while performing
destaticization through said bypass film.

REMARKS

This amendment is filed to claim priority to the parent and Japanese priority application and to incorporate same by reference. Also, the subject matters of claims 9-11 and 13 have been recast as claims 14-17, respectively.

Respectfully submitted,
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